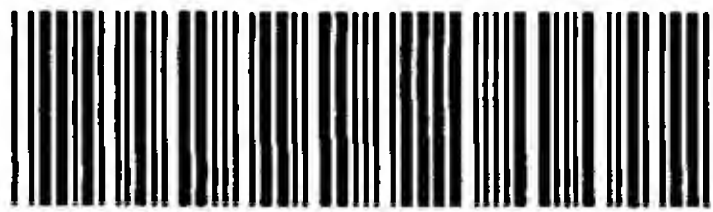


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/707,362	CHEN ET AL.	
	Examiner	Art Unit	
	Mike Fatahiyar	2629	

SEARCHED			
Class	Subclass	Date	Examiner
UPDATE		5/25/2007	MF
345	690-697	5/25/2007	MF

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Interference search history printout		5/28/2007	MF

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST search	5/25/2007	MF
Inventor's name search	5/28/2007	MF